IN THE CLAIMS

Please cancel claims 14 thru 21 and 24 thru 27 without prejudice or disclaimer.

1. (Previously Presented) A mask for a color cathode ray tube, the mask comprising:

a plurality of strips being parallel to each other, being distinguishable from each other, and being located at predetermined intervals; and

a plurality of bridges connecting adjacent ones of said strips to each other and forming slots extending from a first surface of said mask to a second surface of said mask, said slots being penetrated by electron beams, said bridges being indented to a predetermined depth from said first surface of said mask so that a thickness of said mask at a central portion of said bridges is relatively thinner than a thickness of said mask at an outer portion of said bridges;

said plurality of bridges including first bridges near a central region of said mask and including second bridges near a periphery region of said mask away from said central region, a first width of said first bridges as measured perpendicular to a length direction of said slots being smaller than a second width of said second bridges, said first and second widths being measured perpendicular to the length direction of said slots.

2. (Original) The mask of claim 1, said slots formed by said bridges including a first slot, the electron beams entering said first slot at said second surface of said mask and

exiting said first slot at said first surface of said mask, said first slot at said second surface having a first center as measured substantially parallel to said first surface of said mask, said first slot at said first surface having a second center as measured substantially parallel to said first surface of said mask, said first and second centers of said first slot not being aligned with each other.

3. (Previously Presented) The mask of claim 2, said mask having a central region and a periphery region away from said central region, said first slot being located in said periphery region at a first position not close to said central region, said first center being closer to said central region than said second center, said first center being separated from said second center by a first length as measured substantially parallel to said first surface of said mask.

4. (Original) The mask of claim 3, said slots formed by said bridges further including a second slot, the electron beams entering said second slot at said second surface of said mask and exiting said second slot at said first surface of said mask, said second slot at said second surface having a first center as measured substantially parallel to said first surface of said mask, said second slot at said first surface having a second center as measured substantially parallel to said first surface of said mask, said first and second centers of said second slot not being aligned with each other.

5. (Previously Presented) The mask of claim 4, said second slot being located in said periphery region at a position close to said central region, said first center of said second slot being closer to said central region than said second center of said second slot, said first center of said second slot being separated from said second center of said second slot by a second length as measured substantially parallel to said first surface of said mask, said second length being less than said first length.

Claim 6. (Canceled)

7. (Previously Presented) A mask for a color cathode ray tube, the mask comprising:

a plurality of strips being parallel to each other, being distinguishable from each other, and being located at predetermined intervals; and

a plurality of bridges connecting adjacent ones of said strips to each other and forming slots extending from a first surface of said mask to a second surface of said mask, said slots being penetrated by electron beams, said bridges being indented to a predetermined depth from said first surface of said mask so that a thickness of said mask at a central portion of said bridges is relatively thinner than a thickness of said mask at an outer portion of said bridges;

said plurality of bridges forming said slots in a slotted region of said mask, said slots not being formed in a non-slotted region of said mask, said plurality of bridges including

first bridges near a center of said slotted region of said mask and including second bridges near a periphery of said slotted region away from said center, said first bridges being indented to a first predetermined depth, said second bridges being indented to a second predetermined depth, said first predetermined depth being deeper than said second predetermined depth.

8. (Original) The mask of claim 1, said plurality of bridges including first bridges near a central region of said mask and including second bridges near a periphery region of said mask away from said central region, a vertical length of said first bridges as measured substantially parallel to a length direction of said slots being smaller than a vertical length of said second bridges as measured substantially parallel to the length direction of said slots.

9. (Original) The mask of claim 1, each one of said slots formed by said plurality of bridges having a first curved portion adjacent to an upper surface of said mask and having a second curved portion adjacent to a lower surface said mask, said first curved portion extending in the length direction of said strips and having a first width as measured substantially perpendicular to a length direction of said strips, said second curved portion extending in the length direction of said strips and having a second width as measured substantially perpendicular to the length direction of said strips, said first width being larger than said second width.

10. (Original) The mask of claim 9, said slots formed by said bridges including a first slot, the electron beams entering said first slot at said second surface of said mask and exiting said first slot at said first surface of said mask, said first slot at said second surface having a first center as measured substantially parallel to said first surface of said mask, said first slot at said first surface having a second center as measured substantially parallel to said first surface of said mask, said first and second centers of said first slot not being aligned with each other.

11. (Previously Presented) The mask of claim 10, said mask having a central region and a periphery region away from said central region, said first slot being located in said periphery region at a first position not close to said central region, said first center being closer to said central region than said second center, said first center being separated from said second center by a first length as measured substantially parallel to said first surface of said mask.

12. (Original) The mask of claim 11, said slots formed by said bridges further including a second slot, the electron beams entering said second slot at said second surface of said mask and exiting said second slot at said first surface of said mask, said second slot at said second surface having a first center as measured substantially parallel to said first surface of said mask, said second slot at said first surface having a second center as measured substantially parallel to said first surface of said mask, said first and second centers of said

second slot not being aligned with each other.

13. (Previously Presented) The mask of claim 12, said second slot being located in said periphery region at a position close to said central region, said first center of said second slot being closer to said central region than said second center of said second slot, said first center of said second slot being separated from said second center of said second slot by a second length as measured substantially parallel to said first surface of said mask, said second length being less than said first length.

Claims 14 thru 21. (Canceled)

22. (Previously Presented) The mask of claim 1, said plurality of strips corresponding to light blocking strips, said first surface of said mask corresponding to an upper surface of said mask, said second surface of said mask corresponding to a lower surface of said mask, said mask being manufactured by coating upper and lower surfaces of said mask with photosensitive films, arranging an upper exposure device on said upper surface of said mask, said upper exposure device having an exposure pattern with upper light transmission strips being formed in parallel to each other, arranging a lower exposure device on said lower surface of said mask, said lower exposure device having an exposure pattern with lower light transmission strips being formed in parallel to each other and having lower light blocking bridges separating said lower light transmission strips, exposing said

photosensitive films to light in a state where said upper and lower exposure devices are arranged on said mask, separating said upper and lower exposure devices from said mask, developing said photosensitive films on said mask, etching said mask when said developing of said photosensitive films is performed, and molding said mask to have a predetermined curvature.

23. (Previously Presented) The mask of claim 1, said plurality of strips corresponding to light blocking strips, said first surface of said mask corresponding to an upper surface of said mask, said second surface of said mask corresponding to a lower surface of said mask, said mask being formed by an exposure mask assembly, said exposure mask assembly comprising:

an upper exposure device being closely attached to said upper surface of said mask, said upper surface being coated with photosensitive films, said upper exposure device having an exposure pattern with upper light transmission strips being formed in parallel to each other; and

a lower exposure device being closely attached to said lower surface of said mask, said lower surface being coated with photosensitive films, said lower exposure device having an exposure pattern with lower light transmission strips being formed in parallel to each other and having lower light blocking bridges separating said lower light transmission strips, said lower light blocking bridges blocking light;

said photosensitive films on said upper and lower surfaces being exposed to light

penetrating said upper and lower exposure devices through said upper and lower light transmission strips, respectively.

Claims 24 thru 27. (Canceled)